

<b>Notice of References Cited</b>	Application/Control No. 10/643,772		Applicant(s)/Patent Under Reexamination DEHON ET AL.	
	Examiner Leigh Marie Garbowski		Art Unit 2825	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,292,929	09-2001	Scepanovic et al.	716/14
*	B	US-6,155,725	12-2000	Scepanovic et al.	716/9
*	C	US-6,080,204	06-2000	Mendel, David Wolk	716/7
*	D	US-5,815,403	09-1998	Jones et al.	716/9
*	E	US-5,638,292	06-1997	Ueda, Toshiaki	716/8
*	F	US-5,465,218	11-1995	Handa, Keiichi	716/8
*	G	US-5,200,908	04-1993	Date et al.	716/10
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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